

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	250				
R _{DS(on)} (Ω)	V _{GS} = 10 V 0.64				
Q _g (Max.) (nC)	14				
Q _{gs} (nC)	2.7				
Q _{gd} (nC)	7.8				
Configuration	Single				

FEATURES

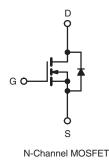
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Available in Tape and Reel
- Fast Switching
- Ease of Paralleling





DPAK





ABSOLUTE MAXIMUM RATINGS (TC	; = 25 °C, un	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	250	v	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V _{GS} at 10 V	$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$	1-	4.5		
Continuous Drain Current	VGS at TO V	T _C = 100 °C	Ι _D	3.0	А	
Pulsed Drain Current ^a			I _{DM}	16		
Linear Derating Factor				0.33	W/°C	
Linear Derating Factor (PCB Mount) ^e				0.020	W/-C	
Single Pulse Avalanche Energy ^b			E _{AS}	130	mJ	
Repetitive Avalanche Current ^a			I _{AR}	4.5	A	
Repetitive Avalanche Energy ^a			E _{AR}	5.2	mJ	
Maximum Power Dissipation	T _C =	T _C = 25 °C		45		
Maximum Power Dissipation (PCB Mount) ^e	T _A = 25 °C		PD	2.5	W	
Peak Diode Recovery dV/dtc			dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg} - 55 to + 150	*0		
Soldering Recommendations (Peak Temperature) ^d	for	for 10 s		260	- °C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50 \text{ V}$; starting $T_J = 25 \text{ °C}$, L = 14 mH, $R_g = 25 \Omega$, $I_{AS} = 3.8 \text{ A}$ (see fig. 12). c. $I_{SD} \le 3.8 \text{ A}$, dl/dt $\le 90 \text{ A/}\mu$ s, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$.

d. 1.6 mm from case.

e. When mounted on 1" square PCB (FR-4 or G-10 material) .



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	50			
Maximum Junction-to-Ambient	R _{thJA}	-	110	°C/W		
Maximum Junction-to-Case	R _{thJC}	-	3.0			

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							1
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA		250	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C, I _D = 1 mA	-	0.36	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
		V _{DS} = 250 V, V _{GS} = 0 V		-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 200 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D = 2.3 A ^b	-	0.64	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 2.3 A ^b	1.5	-	-	S
Dynamic					•	•	
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	260	-	pF
Output Capacitance	Coss		V _{DS} = 25 V,	-	77	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.	f = 1.0 MHz, see fig. 5 ^c		15	-	
Total Gate Charge	Qg			-	-	14	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$	$V_{GS} = 10 \text{ V} \qquad \begin{array}{c} I_D = 4.4 \text{ A}, V_{DS} = 200 \text{ V}, \\ \text{see fig. 6 and } 13^{\text{b, c}} \end{array}$		-	2.7	nC
Gate-Drain Charge	Q _{gd}				-	7.8	
Turn-On Delay Time	t _{d(on)}				7.0	-	- ns
Rise Time	t _r	$\label{eq:V_DD} \begin{array}{l} V_{DD} = 125 \; V, \; I_D = 4.4 \; A, \\ R_G = 18 \; \Omega, \; R_D = 28 \; \Omega, \\ \text{see fig. 10^{b, \; c}} \end{array}$		-	13	-	
Turn-Off Delay Time	t _{d(off)}			-	20	-	
Fall Time	t _f			-	12	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s	·					
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	3.8	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	-	15	
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = 3.8 \ A, \ V_{GS} = 0 \ V^b$		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 4.4 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{b}$		-	200	400	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.93	1.9	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	-on is dor	ninated b	y L _S and	L _D)

Notes a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

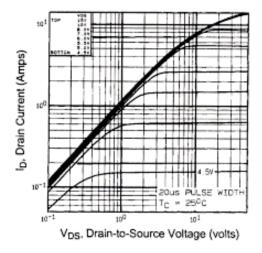


Fig. 1 - Typical Output Characteristics, $T_C = 25 \ ^{\circ}C$

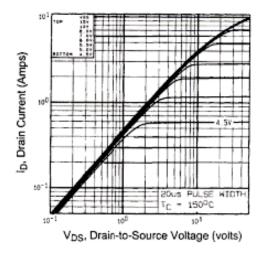


Fig. 2 - Typical Output Characteristics, T_C = 150 $^\circ C$

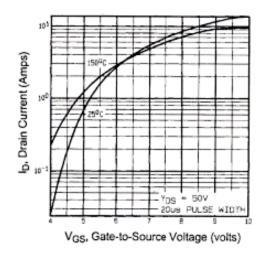


Fig. 3 - Typical Transfer Characteristics

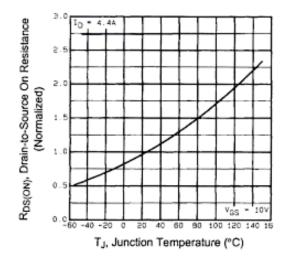


Fig. 4 - Normalized On-Resistance vs. Temperature



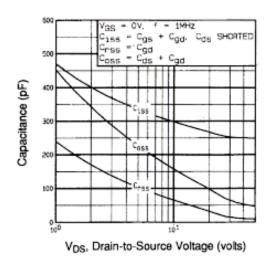
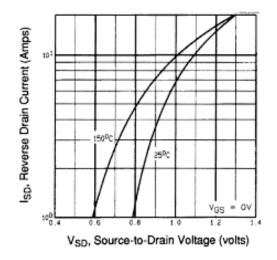


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





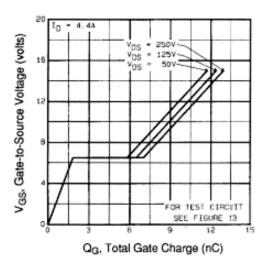


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

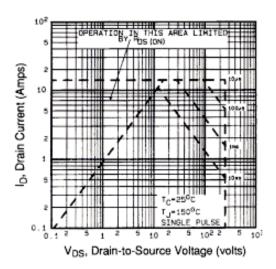


Fig. 8 - Maximum Safe Operating Area



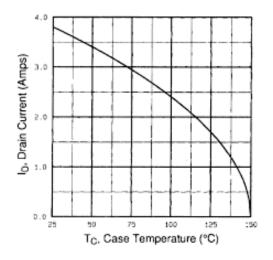


Fig. 9 - Maximum Drain Current vs. Case Temperature

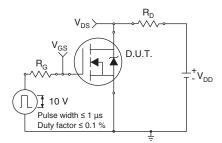


Fig. 10a - Switching Time Test Circuit

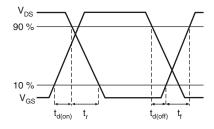


Fig. 10b - Switching Time Waveforms

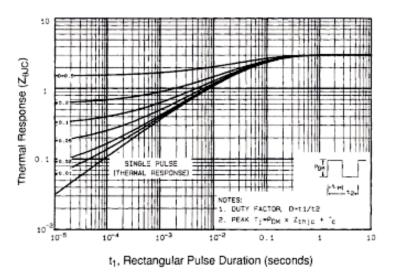


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



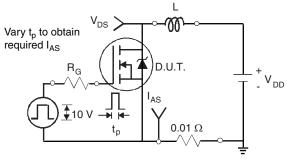


Fig. 12a - Unclamped Inductive Test Circuit

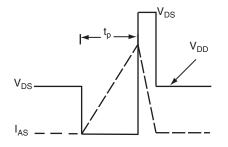


Fig. 12b - Unclamped Inductive Waveforms

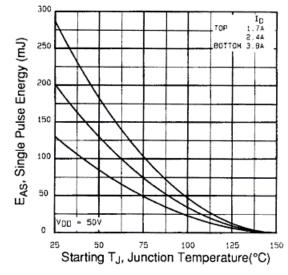


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

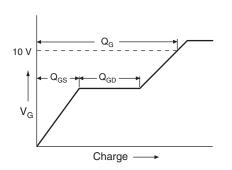


Fig. 13a - Basic Gate Charge Waveform

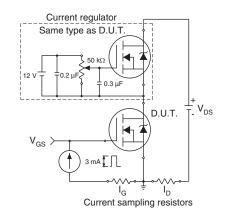


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

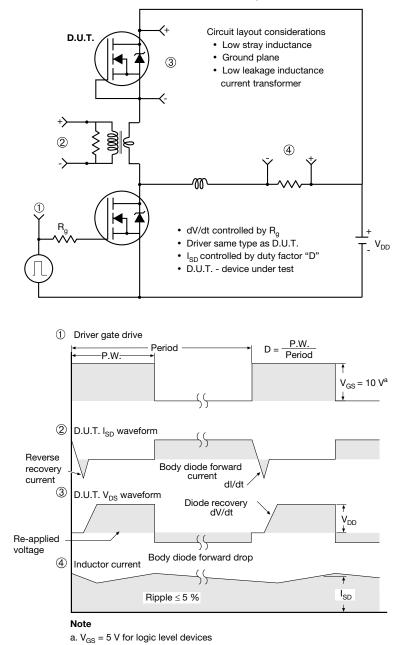
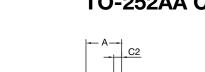
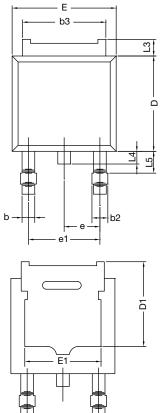


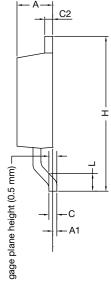
Fig. 14 - For N-Channel





TO-252AA Case Outline





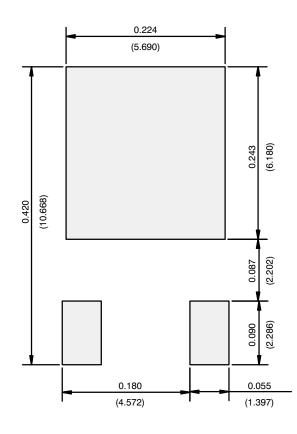
	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	4.10	-	0.161	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090 BSC		
e1	4.56	4.56 BSC		0.180 BSC	
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.01	1.52	0.040	0.060	
ECN: T16-0236-Rev. P, 16-May-16 DWG: 5347					

Notes

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)



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